

**Notice of References Cited**

Application/Control No.

09/929,995

Applicant(s)/Patent Under  
Reexamination  
TERNULLO ET AL.

Examiner

SARGON N. NANO

Art Unit

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**U.S. PATENT DOCUMENTS**

★		Document Number		Date	Name	Classification
		Country Code-Number-Kind Code		MM-YYYY		
★	A	US-2002/0087596		07-2002	Lewontin, Steve	707/513
	B	US-				
	C	US-				
	D	US-				
	E	US-				
	F	US-				
	G	US-				
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	K	US-				
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**FOREIGN PATENT DOCUMENTS**

★		Document Number		Date	Country	Name	Classification
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